

13. TEST SETUP PHOTOGRAPHS

FCC ID: ZNFH910		HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename: 0Y1608121362.ZNF	Test Dates: 08/09/2016 - 08/11/2016	DUT Type: Portable Handset		Page 50 of 52

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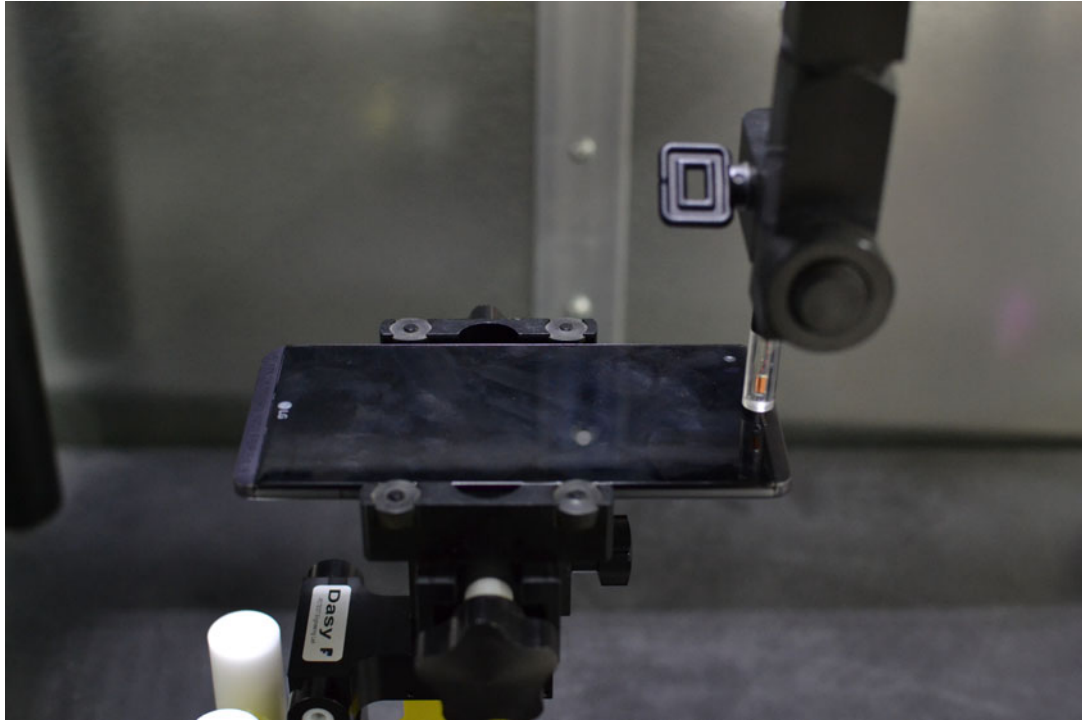


Figure 13-1
Test Setup for Wireless Device

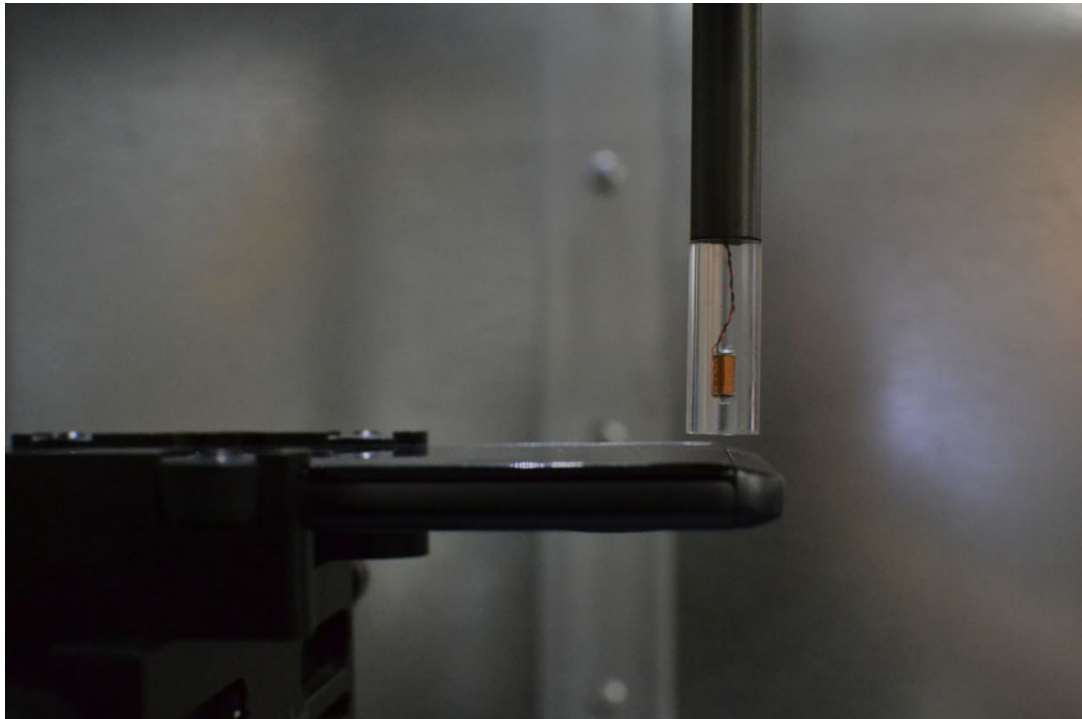


Figure 13-2
Test Setup for Wireless Device

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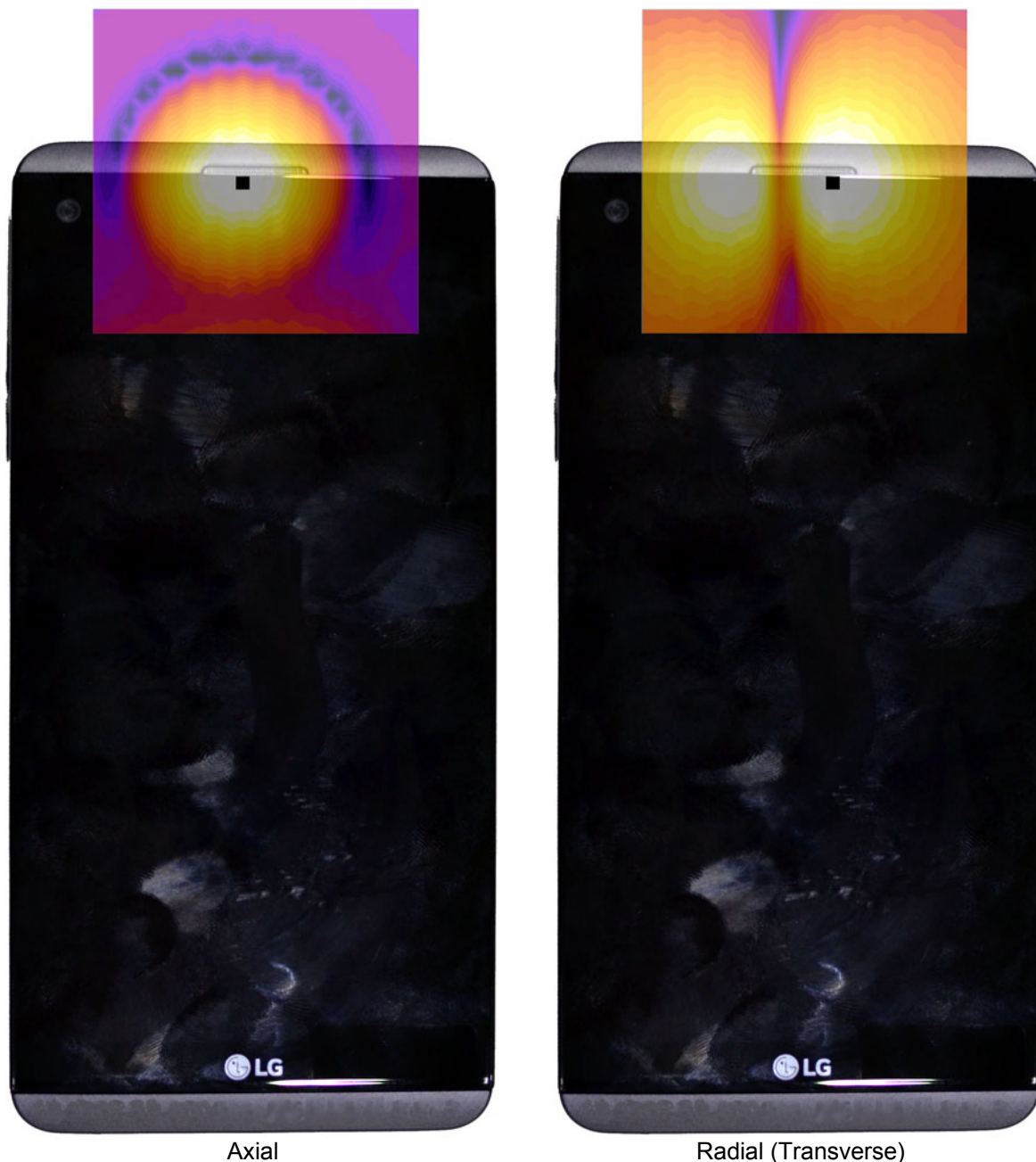


Figure 13-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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